

SHEET 1 OF 1

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

216971US2

SERIAL NO.

10/003,432

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Hiroyuki MIYAKE, et al.

FILING DATE

December 6, 2001

GROUP

2622

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

RECEIVED

MAY 12 2004

Technology Center 2600

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
7/11	AO	2000-10165	01/14/2000	JAPAN		X
	AP	2001-108879	04/20/2001	JAPAN		X
✓	AQ	8-181894	07/12/1996	JAPAN		X
	AR					
	AS					
	AT					
	AU					
	AV					

No Abstract Trans.
provided

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

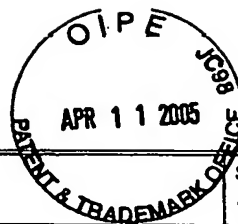
☐ Additional References sheet(s) attached

Examiner

Date Considered

4/10/04

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



SHEET 1 OF 1

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

216971US2

SERIAL NO.

10/003,432

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Hiroyuki MIYAKE, et al.

FILING DATE

December 6, 2001

GROUP

2622

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
7/1	AO	2-179081	07/12/1990	Japan (with English Abstract)		X
	AP	1-319375	12/25/1989	Japan (with English Abstract)		X
	AQ	10-4540	01/06/1998	Japan (with English Abstract)		X
	AR	10-285499	10/23/1998	Japan (with English Abstract)		X
V	AS	8-140072	05/31/1996	Japan (with English Abstract)		X
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

Date Considered

4/10/06

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



Form PTO 1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY DOCKET NO.	SERIAL NO.
		216971US2	10/003,432
		APPLICANT	
		Hiroyuki MIYAKE, et al.	
LIST OF REFERENCES CITED BY APPLICANT		FILING DATE	GROUP
		December 6, 2001	2622

U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

RECEIVED
DEC 03 2003
Technology Center 2600

FOREIGN PATENT DOCUMENTS						
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
7/1	AO	10-108152	04/24/1998	JAPAN (with English Abstract)		X
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)		
	AW	
	AX	
	AY	
	AZ	
		<input type="checkbox"/> Additional References sheet(s) attached

Examiner <i>[Signature]</i>	Date Considered 4/10/06
-----------------------------	-------------------------

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



SHEET 1 OF 1

RECEIVED
JUL 21 2003
Technology Center 2600

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 216971US2		SERIAL NO. 10/003,432	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Hiroyuki MIYAKE, et al.		GROUP 2622	
				FILING DATE December 6, 2001			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
#	AO	04-152765	05/26/92	JAPAN (with English Abstract)			X
	AP	62-141863	06/25/87	JAPAN (with English Abstract)			X
↓	AQ	07-184102	07/21/95	JAPAN (with English Abstract)			X
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner <i>[Signature]</i>					<input type="checkbox"/> Additional References sheet(s) attached		
Date Considered <i>4/10/06</i>							
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							